New Product

P-Channel 12-V (D-S) MOSFET

PRODUCT SUMMARY		
V_{DS} (V)	$r_{DS(on)}$ (Ω)	I_D (A)
- 12	0.00825 at V_{GS} = - 4.5 V	- 14
	0.01025 at V_{GS} = - 2.5 V	- 13
	0.013 at V_{GS} = - 1.8 V	- 12

FEATURES

- TrenchFET® Power MOSFET

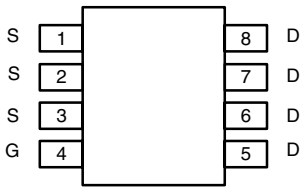
APPLICATIONS

- Load Switch
- Battery Switch

Pb-free Available

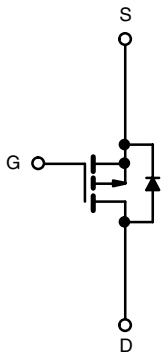
RoHS* COMPLIANT

SO-8



Top View

Ordering Information: Si4451DY-T1
Si4451DY-T1-E3 (Lead (Pb)-free)



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T_A = 25 °C, unless otherwise noted					
Parameter		**Symbol**	**10 sec**	**Steady State**	**Unit**
Drain-Source Voltage		V_{DS}	- 12		V
Gate-Source Voltage		V_{GS}	± 8		
Continuous Drain Current (T_J = 150 °C)[a]	T_A = 25 °C	I_D	- 14	- 10	A
	T_A = 70 °C		- 11	- 8	
Pulsed Drain Current		I_{DM}	- 40		
Continuous Source Current (Diode Conduction)[a]		I_S	- 2.7	- 1.35	
Maximum Power Dissipation[a]	T_A = 25 °C	P_D	3.0	1.5	W
	T_A = 70 °C		1.9	0.95	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	- 55 to 150		°C

THERMAL RESISTANCE RATINGS					
Parameter		**Symbol**	**Typical**	**Maximum**	**Unit**
Maximum Junction-to-Ambient[a]	t ≤ 10 sec	R_{thJA}	33	42	°C/W
	Steady State		70	85	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	17	21	

Notes:
a. Surface Mounted on 1" x 1" FR4 Board.

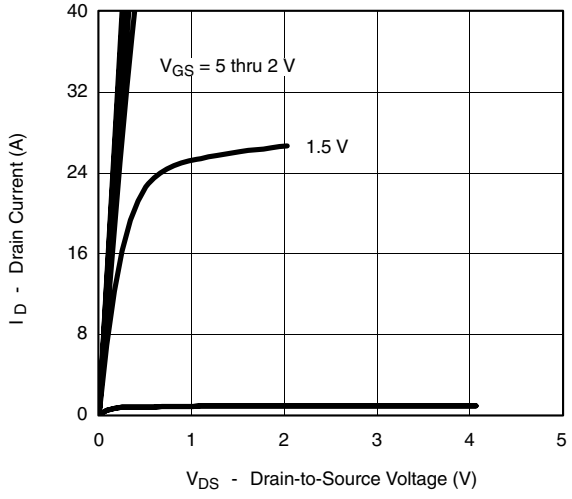
* Pb containing terminations are not RoHS compliant, exemptions may apply.

SPECIFICATIONS T_J = 25 °C, unless otherwise noted						
Parameter	**Symbol**	**Test Conditions**	**Min**	**Typ**	**Max**	**Unit**
Static						
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = - 850 µA	- 0.40		- 0.8	V
Gate-Body Leakage	I_{GSS}	V_{DS} = 0 V, V_{GS} = ± 8 V			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = - 12 V, V_{GS} = 0 V			- 1	µA
		V_{DS} = - 12 V, V_{GS} = 0 V, T_J = 70 °C			- 5	
On-State Drain Current[a]	$I_{D(on)}$	V_{DS} = - 5 V, V_{GS} = - 4.5 V	- 30			A
Drain-Source On-State Resistance[a]	$r_{DS(on)}$	V_{GS} = - 4.5 V, I_D = - 14 A		0.0065	0.00825	Ω
		V_{GS} = - 2.5 V, I_D = - 13 A		0.008	0.01025	
		V_{GS} = - 1.8 V, I_D = - 12 A		0.0105	0.013	
Forward Transconductance[a]	g_{fs}	V_{DS} = - 10 V, I_D = - 14 A		55		S
Diode Forward Voltage[a]	V_{SD}	I_S = - 2.7 A, V_{GS} = 0 V		- 0.6	- 1.1	V
Dynamic[b]						
Total Gate Charge	Q_g	V_{DS} = - 6 V, V_{GS} = - 4.5 V, I_D = - 14 A		81	120	nC
Gate-Source Charge	Q_{gs}			8.6		
Gate-Drain Charge	Q_{gd}			23.4		
Gate Resistance	R_g			3.0		Ω
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = - 6 V, R_L = 6 Ω $I_D \cong$ - 1 A, V_{GEN} = - 4.5 V, R_G = 6 Ω		55	85	ns
Rise Time	t_r			125	190	
Turn-Off Delay Time	$t_{d(off)}$			315	480	
Fall Time	t_f			235	360	
Source-Drain Reverse Recovery Time	t_{rr}	I_F = - 2.7 A, di/dt = 100 A/µs		185	300	

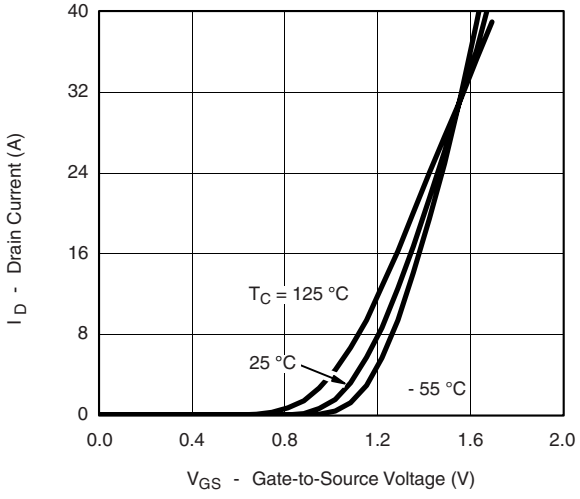
Notes:
a. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2 %.
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS 25 °C unless noted



Output Characteristics



Transfer Characteristics

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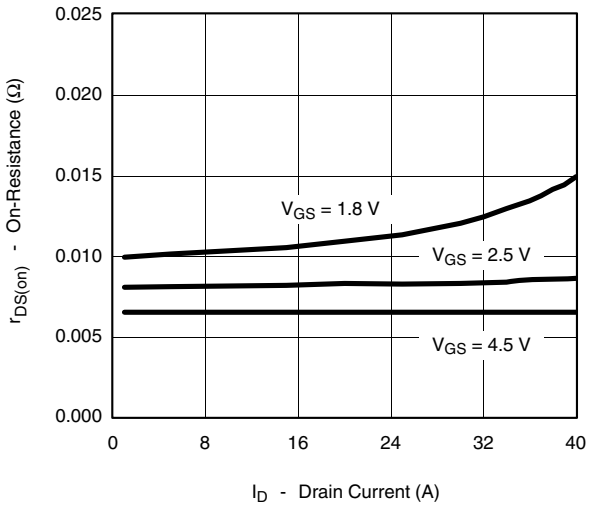
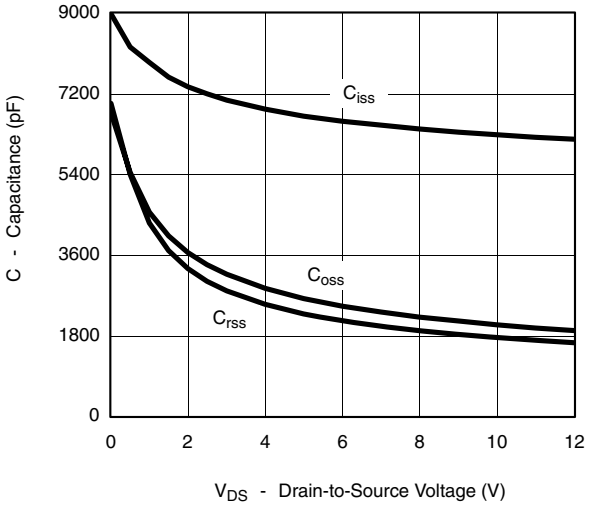
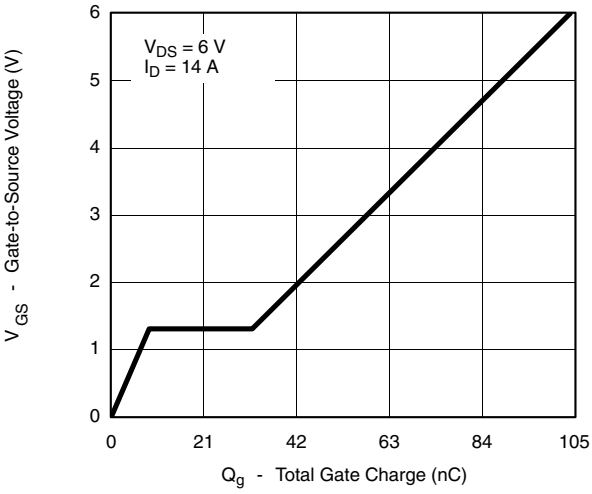


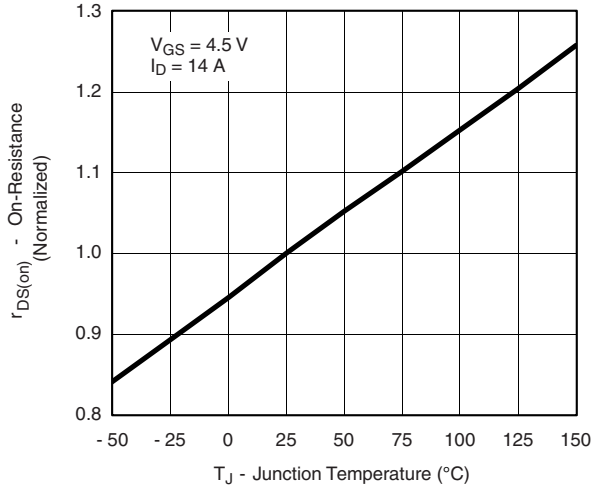
On-Resistance vs. Drain Current



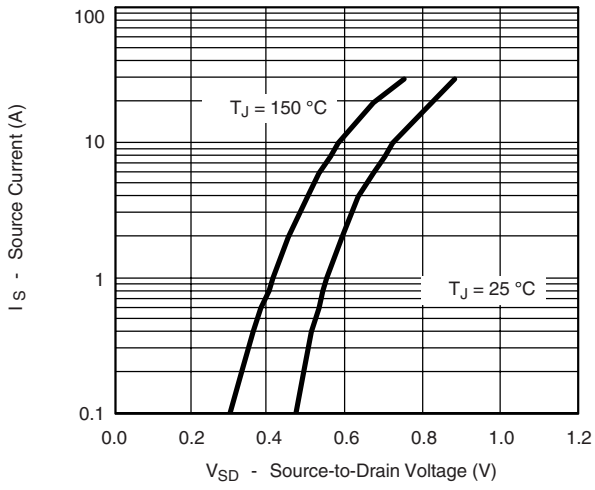
Capacitance



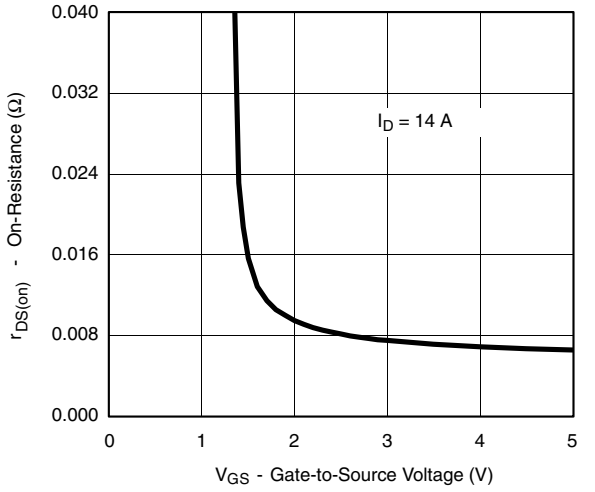
Gate Charge



On-Resistance vs. Junction Temperature

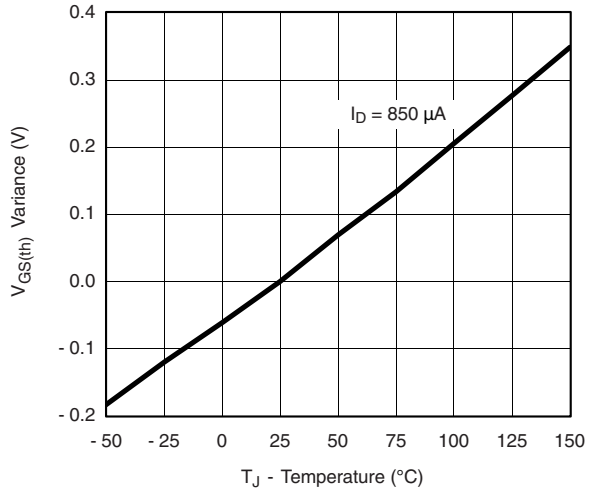


Source-Drain Diode Forward Voltage

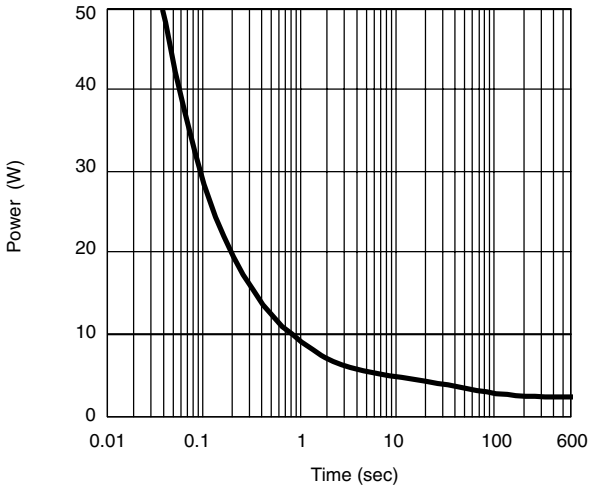


On-Resistance vs. Gate-to-Source Voltage

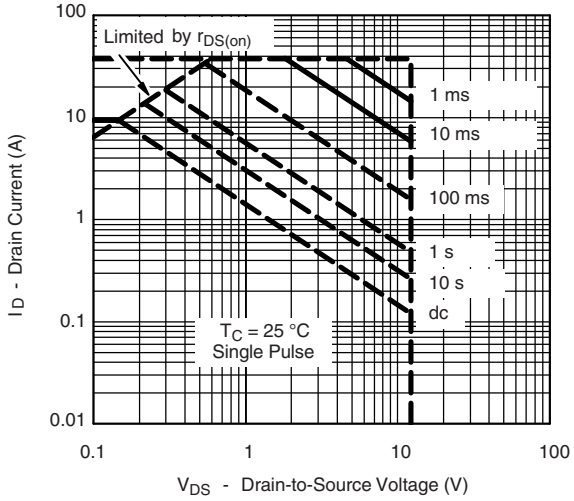
TYPICAL CHARACTERISTICS 25 °C unless noted



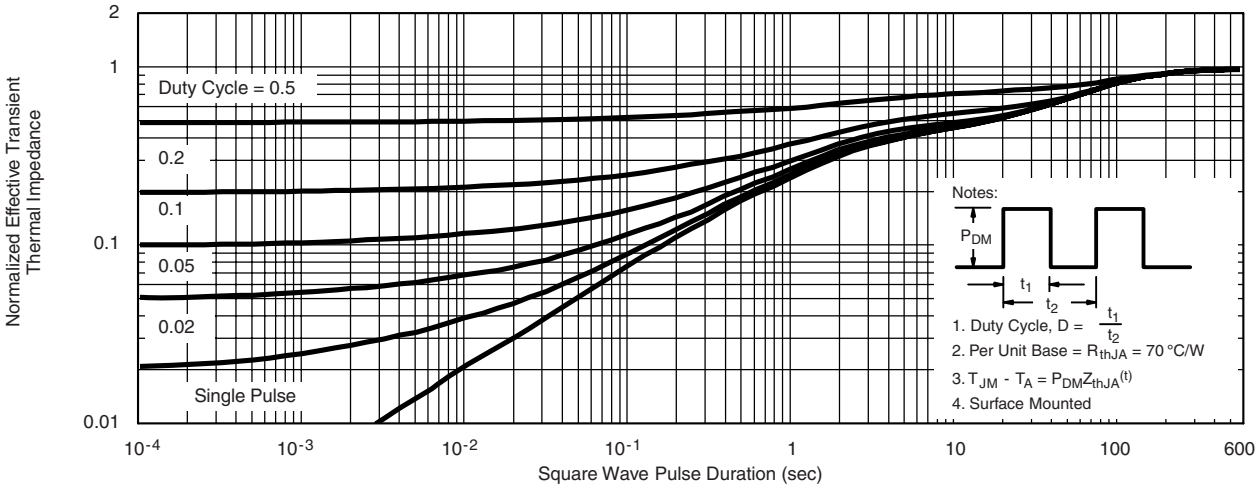
Threshold Voltage



Single Pulse Power

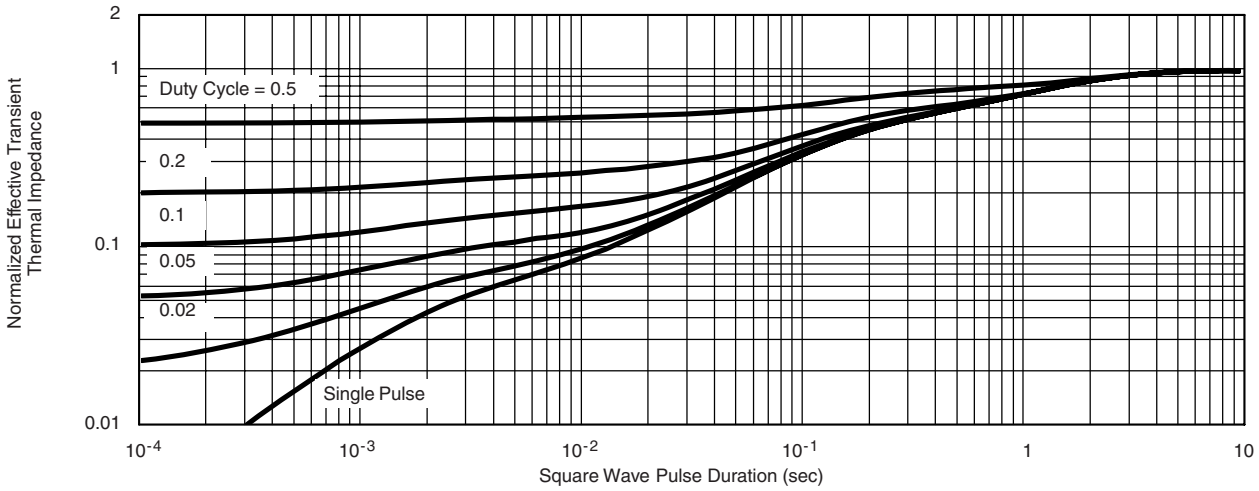


Safe Operating Area, Junction-to-Case



Normalized Thermal Transient Impedance, Junction-to-Ambient

TYPICAL CHARACTERISTICS 25 °C unless noted



Normalized Thermal Transient Impedance, Junction-to-Foot

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